

ZXTN25020DFL 20V, SOT23, NPN low power transistor

Summary

BV_{CEX} > 100V

 $BV_{CEO} > 20V$

 $BV_{ECO} > 5V$

 $I_{C(cont)} = 2A$

 $I_{CM} = 8A$

 $V_{CE(sat)} < 70mV @ 1A$

 $R_{CE(sat)} = 55m\Omega$

 $P_{D} = 350 \text{mW}$

Complementary part number ZXTP25020DFL



Advanced process capability has been used to achieve high current gain hold up making this device ideal for applications requiring high pulse currents.

Features

- · High peak current
- · Low saturation voltage
- 100V forward blocking voltage

Applications

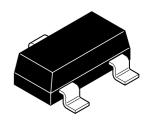
- · MOSFET and IGBT gate driving
- · DC-DC conversion
- · LED driving
- Interface between low voltage IC's and loads

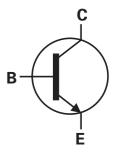
Ordering information

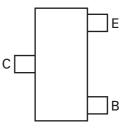
Device	Reel size (inches)	Tape width (mm)	Quantity per reel		
ZXTN25020DFLTA	7	8	3,000		

Device marking

1A1







Pinout - top view

Absolute maximum ratings

Parameter	Symbol	Limit	Unit
Collector-base voltage	V _{CBO}	100	V
Collector-emitter voltage (forward blocking)	V _{CEX}	100	V
Collector-emitter voltage	V _{CEO}	20	V
Emitter-collector voltage (reverse blocking)	V _{ECO}	5	V
Emitter-base voltage	V _{EBO}	7	V
Continuous collector current ^(a)	I _C	2	Α
Base current	I _B	500	mA
Peak pulse current	I _{CM}	8	Α
Power dissipation at T _{amb} =25°C ^(a)	P _D	350	mW
Linear derating factor		2.8	mW/°C
Operating and storage temperature range	T _j , T _{stg}	-55 to 150	°C

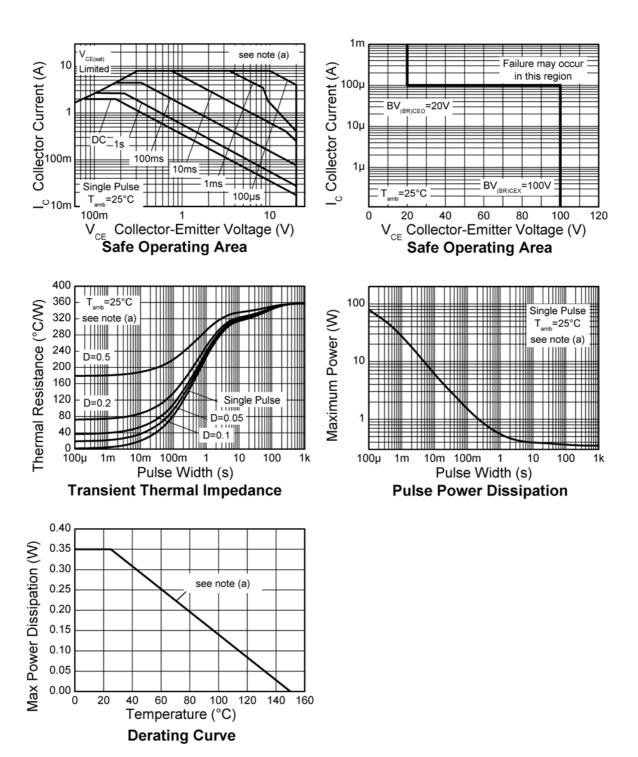
Thermal resistance

Parameter	Symbol	Limit	Unit
Junction to ambient ^(a)	$R_{\Theta JA}$	357	°C/W

NOTES:

(a) For a device surface mounted on 25mm x 25mm x 1.6mm FR4 PCB with high coverage of single sided 1oz copper, in still air conditions.

Characteristics



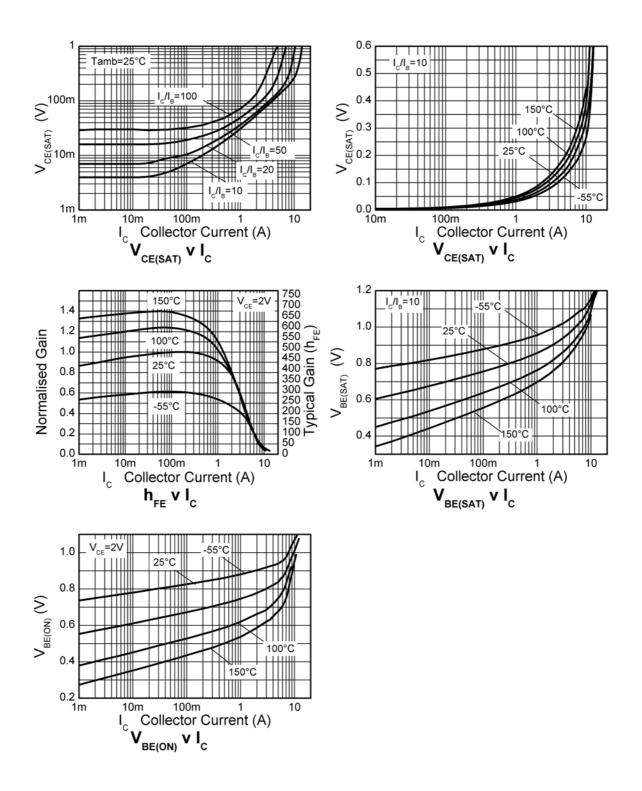
Electrical characteristics (at $T_{amb} = 25$ °C unless otherwise stated)

Parameter	Symbol	Min.	Тур.	Max.	Unit	Conditions
Collector-base breakdown voltage	BV _{CBO}	100	125		V	$I_C = 100 \mu A$
Collector-emitter breakdown voltage (forward blocking)	BV _{CEX}	100	120		V	I_{C} = 100 A; R_{BE} < 1k Ω or -1V < V_{BE} < 0.25V
Collector-emitter breakdown voltage (base open)	BV _{CEO}	20	35		V	I _C = 10mA ^(*)
Emitter-collector breakdown voltage (reverse blocking)	BV _{ECX}	6	8		V	$I_E = 100 \mu A$, $R_{BC} < 1 k \Omega$ or $0.25 V > V_{BC} > -0.25 V$
Emitter-collector breakdown voltage (base open)	BV _{ECO}	5	6		V	$I_E = 100 \mu A$,
Emitter-base breakdown voltage	BV _{EBO}	7	8.3		V	I _E = 100μA
Collector cut-off current	І _{СВО}		<1	50 20	nA μA	$V_{CB} = 80V$ $V_{CB} = 80V, T_{amb} = 100^{\circ}C$
Collector-emitter cut-off current	I _{CEX}		-	100	nA	$V_{CE} = 80V; R_{BE} < 1k\Omega \text{ or} $ -1V < $V_{BE} < 0.25V$
Emitter cut-off current	I _{EBO}		<1	50	nA	V _{EB} = 5.6V
Collector-emitter saturation	V _{CE(SAT)}		60	70	mV	I _C = 1A, I _B = 100mA ^(*)
voltage			85	100	mV	$I_{C} = 1A, I_{B} = 20mA^{(*)}$
			140	160	mV	I _C = 2A, I _B = 40mA ^(*)
			180	225	mV	I _C = 2A, I _B = 20mA ^(*)
			245	270	mV	$I_C = 4,5A, I_B = 450mA^{(*)}$
Base-emitter saturation voltage	V _{BE(SAT)}		895	1000	mV	$I_C = 2A$, $I_B = 40mA^{(*)}$
Base-emitter turn-on voltage	V _{BE(ON)}		825	900	mV	$I_C = 2A, V_{CE} = 2V^{(*)}$
Static forward current transfer ratio	h _{FE}	300	450	900		$I_C = 10 \text{mA}, V_{CE} = 2V^{(*)}$
transier ratio		220	350			$I_C = 2A, V_{CE} = 2V^{(*)}$
		80	120			$I_C = 4.5A, V_{CE} = 2V^{(*)}$
Transition frequency	f _T		215		MHz	I _C = 50mA, V _{CE} = 10V f = 100MHz
Output capacitance	C _{OBO}		16.5	25	pF	V _{CB} = 10V, f = 1MHz ^(*)
Delay time	t _(d)		67.7		ns	V _{CC} = 10V. I _C = 1A,
Rise time	t _(r)		72.2		ns	$I_{B1} = I_{B2} = 10 \text{mA}.$
Storage time	t _(s)		361		ns	
Fall time	t _(f)		63.9		ns	

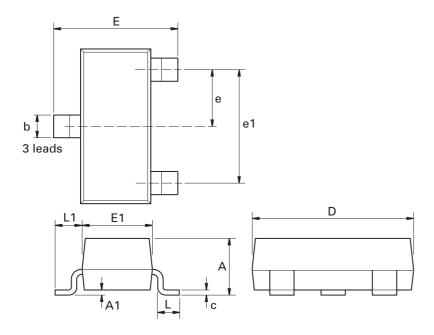
NOTES:

(*) Measured under pulsed conditions. Pulse width ${\leq}300\mu s;$ duty cycle ${\leq}$ 2%.

Typical characteristics



Package outline - SOT23



Dim.	Millim	neters	Inc	hes	Dim.	Millimeters		Inches	
	Min.	Max.	Min.	Max.		Min.	Max.	Max.	Max.
Α	2.67	3.05	0.105	0.120	Н	0.33	0.51	0.013	0.020
В	1.20	1.40	0.047	0.055	K	0.01	0.10	0.0004	0.004
С	-	1.10	-	0.043	L	2.10	2.50	0.083	0.0985
D	0.37	0.53	0.015	0.021	M	0.45	0.64	0.018	0.025
F	0.085	0.15	0.0034	0.0059	N	0.95 N	ЮM	0.0375	NOM
G	1.90	NOM	0.075	NOM	-	-	-	-	-

Note: Controlling dimensions are in millimeters. Approximate dimensions are provided in inches

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Zetex sales offices

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WELL and LLV directives.	
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"Active"	Product status recommended for new designs
"Last time buy (LTB)"	Device will be discontinued and last time buy period and delivery is in effect
"Not recommended for new de	esigns" Device is still in production to support existing designs and production
"Obsolete"	Production has been discontinued
Datasheet status key:	
"Draft version"	This term denotes a very early datasheet version and contains highly provisional information, which may change in any manner without notice.
"Provisional version"	This term denotes a pre-release datasheet. It provides a clear indication of anticipated performance. However, changes to the test conditions and specifications may occur, at any time and without notice.
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